

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 09/653,149
Filing Date August 31, 2000
Inventor Garo J. Derderian, et al.
Assignee Micron Technology, Inc.
Group Art Unit 2818
Examiner T. Lee
Attorney's Docket No. MI22-1330
Title: Capacitor Fabrication Methods Including Forming a Conductive Layer

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

To: Commissioner for Patents
PO Box 1450
Art Unit 2818
Alexandria, VA 22313-1450


From: James E. Lake (Tel. 509-624-4276; Fax 509-838-3424)
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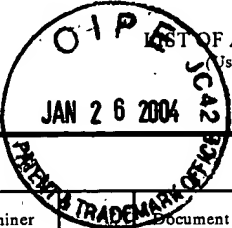
In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art. Citation of these references is respectfully requested.

This Supplemental Information Disclosure Statement is being filed after the filing of the Request for Continued Examination (RCE) Application and before receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Respectfully submitted,

Dated: 26 Jan 2004

By: 
James E. Lake
Reg. No. 44,854

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1330	SERIAL NO. 09/653,149	
				APPLICANT Garo J. Derderian		
				FILING DATE August 31, 2000 GROUP 2812		
U.S. PATENT DOCUMENTS						
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA 6,162,712	12/00	Baum			
	AB 6,018,065	01/00	Baum			
	AC 6,281,543	08/01	Al-Shareef et al			
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
FOREIGN PATENT DOCUMENTS						
	Document Number	Date	Country	Class	Subclass	Translation
						Yes No
	AL					
	AM					
	AN					
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)						
	AO					
	AP					
	AQ					
EXAMINER			DATE CONSIDERED			
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>						